

NIKO-SEM

Dual N-Channel Enhancement Mode Field Effect Transistor

PE5Q8JZ

PDFN 3x3S

Halogen-Free & Lead-Free

PRODUCT SUMMARY

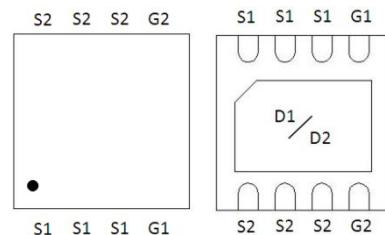
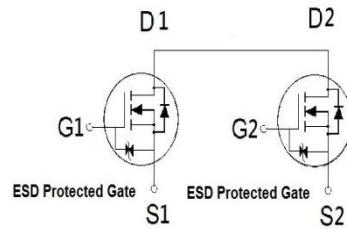
$V_{(BR)DSS}$	$R_{DS(ON)}$	I_D
12V	4.5mΩ	55A

**Features**

- Pb-Free, Halogen Free and RoHS compliant.
- Low $R_{DS(on)}$ to Minimize Conduction Losses.
- Ohmic Region Good $R_{DS(on)}$ Ratio.
- Optimized Gate Charge to Minimize Switching Losses.
- Products Integrated ESD diode

Applications

- Protection Circuits Applications.
- Portable Devices for Battery PACK Applications.

**ABSOLUTE MAXIMUM RATINGS ($T_A = 25^\circ\text{C}$ Unless Otherwise Noted)**

PARAMETERS/TEST CONDITIONS	SYMBOL	LIMITS	UNITS
Drain-Source Voltage	V_{DS}	12	V
Gate-Source Voltage	V_{GS}	± 12	V
Continuous Drain Current ²	I_D	55	A
		35	
		17	
		13	
Pulsed Drain Current ¹	I_{DM}	80	
Avalanche Current	I_{AS}	33	
Avalanche Energy	E_{AS}	54	mJ
Power Dissipation	P_D	28	W
		11	
		2.5	
		1.6	
Operating Junction & Storage Temperature Range	T_j, T_{stg}	-55 to 150	°C

THERMAL RESISTANCE RATINGS

THERMAL RESISTANCE	SYMBOL	TYPICAL	MAXIMUM	UNITS
Junction-to-Ambient ³	$R_{\theta JA}$	50	4.5	°C/W
Junction-to-case	$R_{\theta JC}$			

¹Pulse width limited by maximum junction temperature.

²Package limitation current is 20A.

³The value of $R_{\theta JA}$ is measured with the device mounted on 1in2 FR-4 board with 2oz. Copper, in a still air environment with $T_A = 25^\circ\text{C}$.

NIKO-SEM**Dual N-Channel Enhancement Mode
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PARAMETER	SYMBOL	TEST CONDITIONS	LIMITS			UNIT
			MIN	TYP	MAX	
STATIC						
Drain-Source Breakdown Voltage	$V_{(\text{BR})\text{DSS}}$	$V_{\text{GS}} = 0\text{V}, I_D = 250\mu\text{A}$	12			V
Gate Threshold Voltage	$V_{\text{GS}(\text{th})}$	$V_{\text{DS}} = V_{\text{GS}}, I_D = 250\mu\text{A}$	0.6	0.9	1.2	
Gate-Body Leakage	I_{GSS}	$V_{\text{DS}} = 0\text{V}, V_{\text{GS}} = \pm 10\text{V}$			± 10	μA
Zero Gate Voltage Drain Current	I_{DSS}	$V_{\text{DS}} = 10\text{V}, V_{\text{GS}} = 0\text{V}$			1	
		$V_{\text{DS}} = 10\text{V}, V_{\text{GS}} = 0\text{V}, T_J = 125^\circ\text{C}$			10	μA
Drain-Source On-State Resistance ¹	$R_{\text{DS}(\text{ON})}$	$V_{\text{GS}} = 4.5\text{V}, I_D = 3\text{A}$		3.4	4.5	
		$V_{\text{GS}} = 3.8\text{V}, I_D = 3\text{A}$		3.6	5.1	
		$V_{\text{GS}} = 3.1\text{V}, I_D = 3\text{A}$		4.1	5.8	
		$V_{\text{GS}} = 2.5\text{V}, I_D = 3\text{A}$		4.9	7	
Forward Transconductance ¹	g_{fs}	$V_{\text{DS}} = 5\text{V}, I_D = 3\text{A}$		42.5		S
DYNAMIC						
Input Capacitance	C_{iss}	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 6\text{V}, f = 1\text{MHz}$		1782		
Output Capacitance	C_{oss}			555		pF
Reverse Transfer Capacitance	C_{rss}			379		
Gate Resistance	R_g	$V_{\text{GS}} = 0\text{V}, V_{\text{DS}} = 0\text{V}, f = 1\text{MHz}$		2		Ω
Total Gate Charge ²	$Q_g(V_{\text{GS}}=4.5\text{V})$	$V_{\text{DS}} = 6\text{V}, I_D = 3\text{A}$		17		
	$Q_g(V_{\text{GS}}=3.8\text{V})$			15		
Gate-Source Charge ²	Q_{gs}			2.5		nC
Gate-Drain Charge ²	Q_{gd}			4.1		
Turn-On Delay Time ²	$t_{\text{d}(\text{on})}$	$V_{\text{DD}} = 6\text{V}$ $I_D \approx 3\text{A}, V_{\text{GEN}} = 4.5\text{V}, R_G = 6\Omega$		36		
Rise Time ²	t_r			90		
Turn-Off Delay Time ²	$t_{\text{d}(\text{off})}$			63		
Fall Time ²	t_f			47		nS
SOURCE-DRAIN DIODE RATINGS AND CHARACTERISTICS ($T_J = 25^\circ\text{C}$)						
Continuous Current ³	I_S				23	A
Forward Voltage ¹	V_{SD}	$I_F = 3\text{A}, V_{\text{GS}} = 0\text{V}$			1.2	V
Reverse Recovery Time	t_{rr}	$I_F = 3\text{A}, dI_F/dt = 100\text{A}/\mu\text{s}$		47		nS
Reverse Recovery Charge	Q_{rr}			22		nC

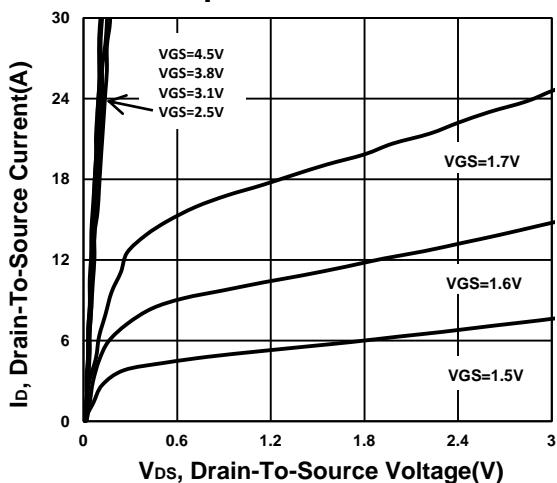
¹Pulse test : Pulse Width $\leq 300\ \mu\text{sec}$, Duty Cycle $\leq 2\%$.²Independent of operating temperature.³Package limitation current is 20A.

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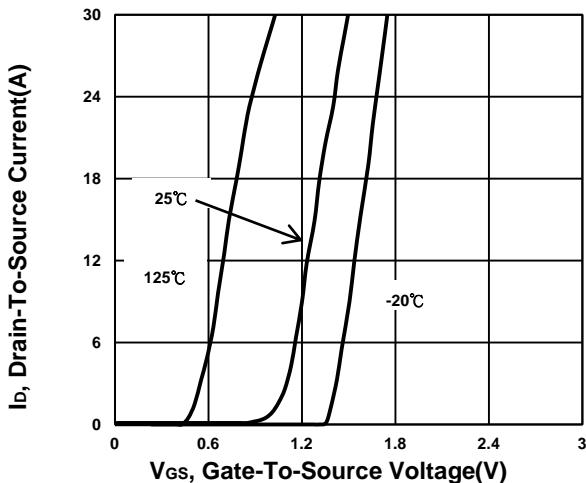
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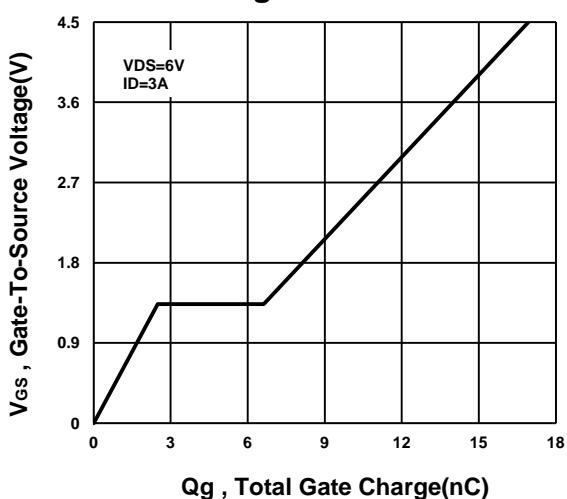
Output Characteristics



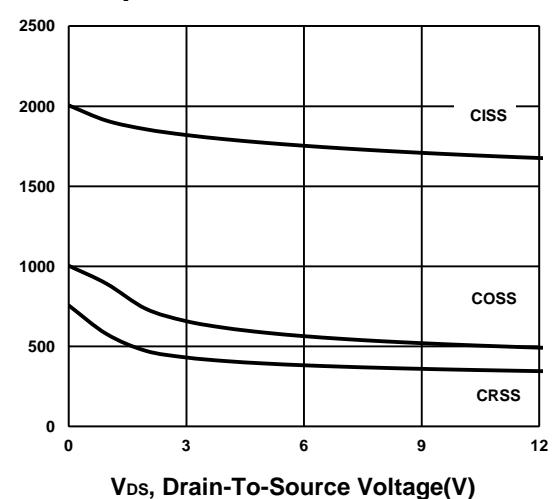
Transfer Characteristics



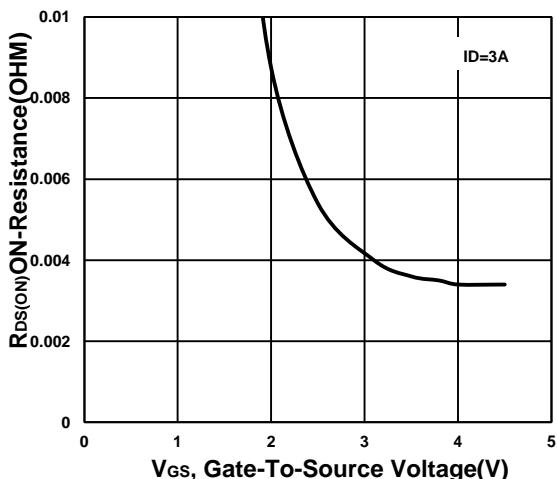
Gate charge Characteristics



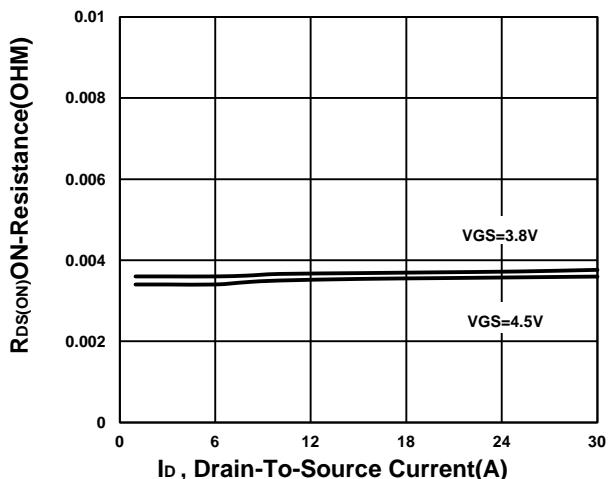
Capacitance Characteristic

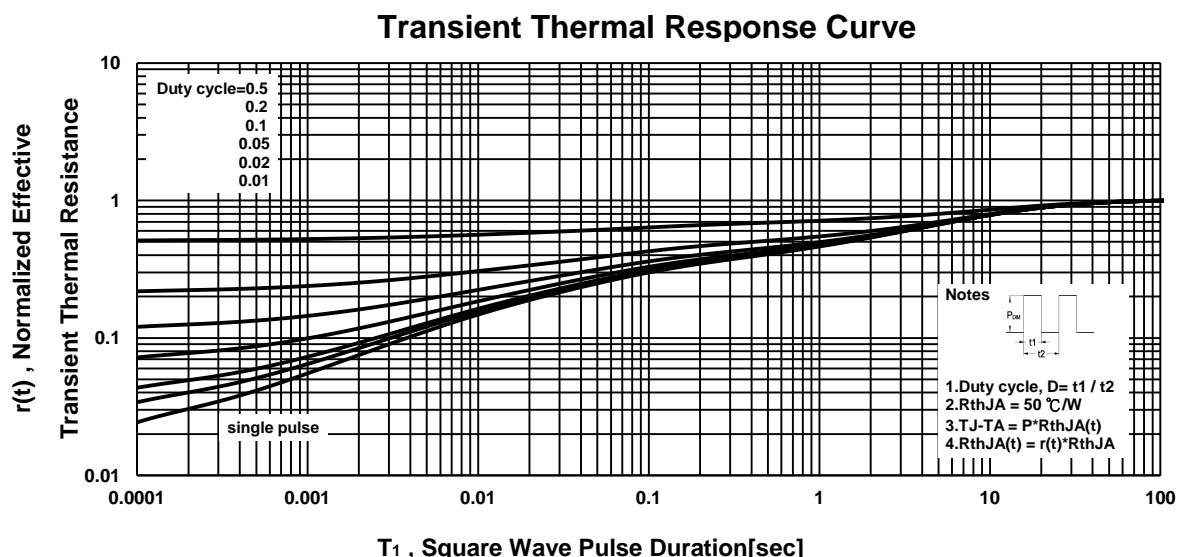
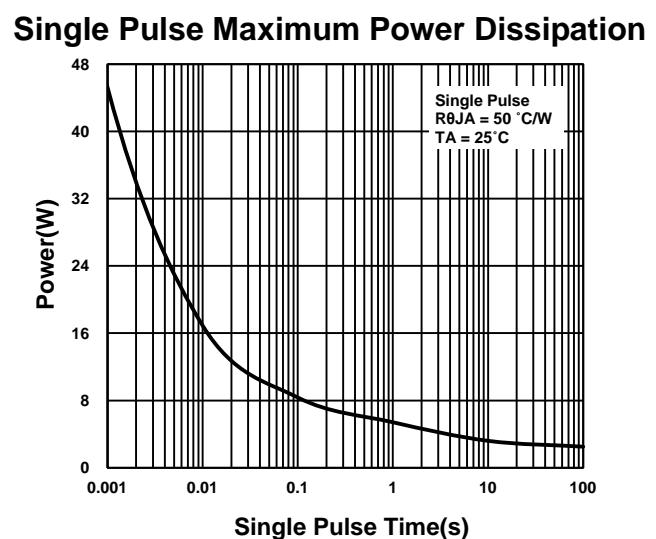
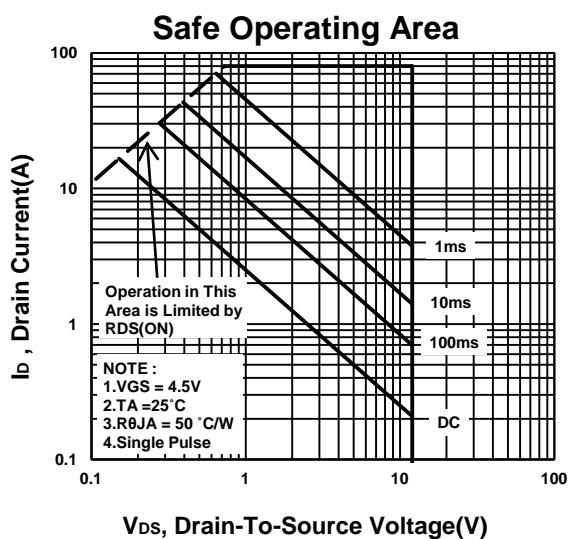
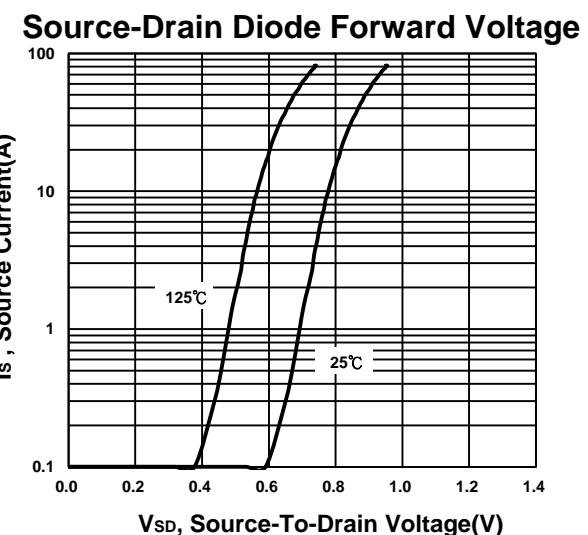
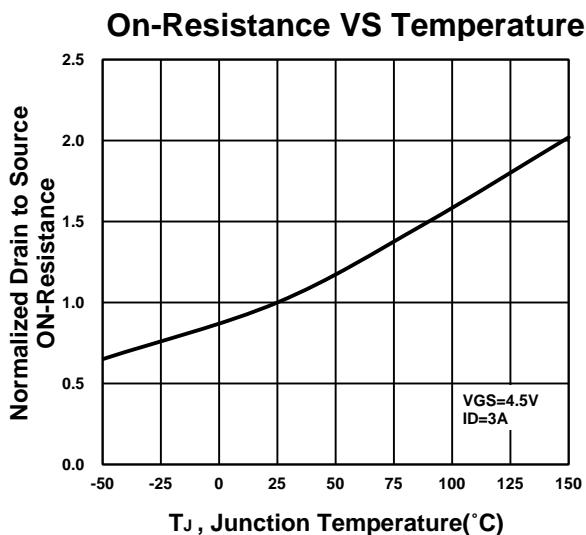


On-Resistance VS Gate-To-Source Voltage



On-Resistance VS Drain Current



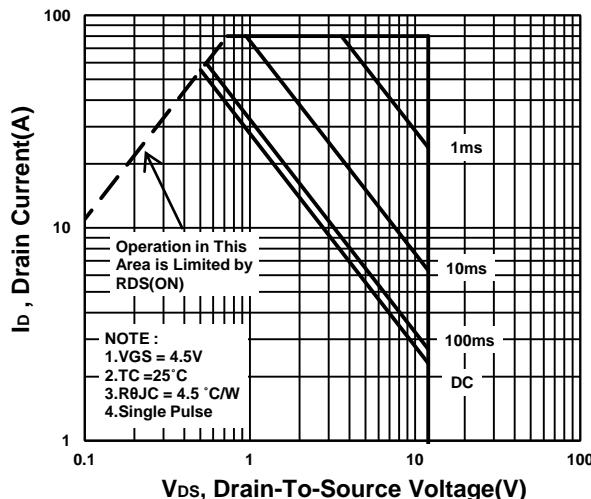
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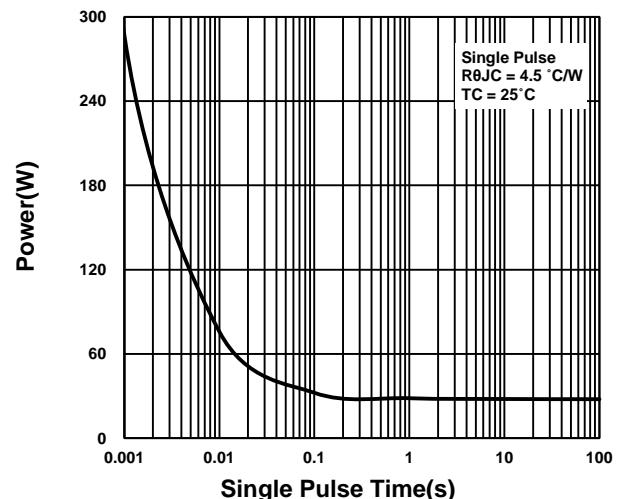
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Safe Operating Area



Single Pulse Maximum Power Dissipation



Transient Thermal Response Curve

